

Notice of References Cited

Application/Control No.

10/553,261

Applicant(s)/Patent Under
Reexamination
LEE ET AL.

Examiner

CATHERYNE CHEN

Art Unit

1655

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0006648 A1	07-2001	YAMAUCHI et al.	424/400
*	B	US-5,869,034	02-1999	Montastier et al.	424/78.03
	C	US-			
	D	US-			
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

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